

## Publikationen

(2018): On the Limits of Scalpel AFM for the 3D Electrical Characterization of Nanomaterials. In: Advanced Functional Materials, vol. 28, no. 52. DOI: 10.1002/adfm.201802266.

(2016): Characterization of the photocurrents generated by the laser of atomic force microscopes. In: Review of Scientific Instruments, vol. 87, no. 8. DOI: 10.1063/1.4960597.